

SIDC161D170H

Fast switching diode chip in EMCON 3-Technology

FEATURES:

- 1700V EMCON 3 technology 200 µm chip
- soft, fast switching
- low reverse recovery charge
- small temperature coefficient

This chip is used for:

EUPEC power modules



Applications:

• resonant applications, drives

Chip Type	V_R	I _F	Die Size	Package	Ordering Code
SIDC161D170H	1700V	300A	12.7 x 12.7 mm ²	sawn on foil	Q67050-A4180- A001

MECHANICAL PARAMETER:

Raster size	12.7 x 12.7		
Area total / active	161.29 / 137.69	mm^2	
Anode pad size	10.68 x 10.68		
Thickness	200	μm	
Wafer size	150	mm	
Flat position	180	deg	
Max. possible chips per wafer	80 pcs		
Passivation frontside	Photoimide		
Anode metallization 3200 nm Al Si Cu			
Cathode metallization	Ni Ag -system suitable for epoxy and soft solder die bonding		
Die bond	electrically conductive glue or solder		
Wire bond	e bond Al, ≤500μm		
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm		
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C		



SIDC161D170H

Maximum Ratings

Parameter	Symbol	Condition	Value	Unit
Repetitive peak reverse voltage	V_{RRM}		1700	V
Continuous forward current limited by T_{jmax}	I _F		300	
Single pulse forward current (depending on wire bond configuration)	I _{FSM}	$t_P = 10 \text{ ms sinusoidal}$	1250	А
Maximum repetitive forward current limited by T _{jmax}	I _{FRM}		600	
Operating junction and storage temperature	$T_{\rm j}$, $T_{ m stg}$		-55+150	°C

Static Electrical Characteristics (tested on chip), T_j =25 °C, unless otherwise specified

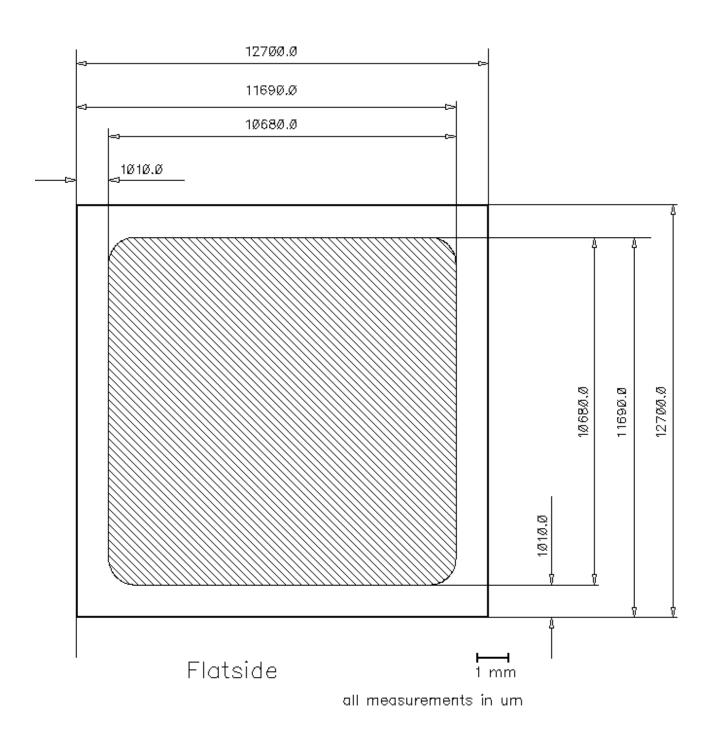
Parameter	Symbol	Condi	Value			Unit	
i arameter	Symbol	Condi	itions	min. Typ. max.		max.]
Reverse leakage current	I_{R}	V _R =1700V	<i>T_j</i> =25 °C			27	μΑ
Cathode-Anode breakdown Voltage	V_{Br}	I _R =0.25mA	<i>T_j</i> =25°C	1700			V
Forward voltage drop	V _F	I _F =300A	<i>T_j</i> =25 °C		1.8		V

Dynamic Electrical Characteristics, at $T_j = 25$ °C, unless otherwise specified, tested at component

Parameter	Symbol	Conditions		Value			Unit
raiailletei	Symbol		tions	min.	Тур.	max.	
Peak recovery current	I_{RRM1}	I _F =300A	$T_j = 25 ^{\circ}C$		233		Α
	I_{RRM2}	$\frac{di/dt=1200A/ms}{V_R=900V}$	$T_j = 125 ^{\circ}C$		275]^
Reverse recovery charge	Q _{rr1}	$I_F = 300A$ di/dt = 1200A/ms $V_R = 900V$	<i>T_j</i> =25 °C		69.6		μC
	Q _{rr2}		T _j =125°C		120.8		¬μο
Peak recovery energy	E _{rec 1}	I _F =300A	T _j =25°C		49.2		
	E _{rec2}	$di/dt=1200A/ms$ $V_R=900V$	T _j =125°C		87.5		mJ



CHIP DRAWING:



L451A1



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FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet line infine on Technologies / tbd

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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